Integrated Device 6024 Silver Creek PRODUCT	Technology, Inc. Valley Road, San	Jose, CA - 95138 S CHANGE NOTI	CE (PCN)
PCN #: A1205-02 Date: July Product Affected: 3.2mm x 5.0mm VFQFPN 2.5mm x 2.0mm VFQFPN (Refer to Attachment 2 for	27, 2012 J-4 J-4 r affected part#)	MEANS OF DISTINGUISHIN Product Mark Lot # Back Mark Date Code Other	NG CHANGED DEVICES: will have "R" prefix
Date Effective: October 27, 2012			
Contact:Mary VeseyTitle:Director, Product AssurancePhone #:(408) 284-4565Fax #:(408) 284-1450E-mail:mary.vesey@idt.com	Attachmer Samples:	nt: Yes Samples are available now.	☐ No
DESCRIPTION AND PURPOSE OF CHANC	GE:		
 Die Technology Wafer Fabrication Process Assembly Process Equipment Material 	This change is to (ASEK) on the se IDT Subcontracto	provide for additional capacity elective products of VFQFPN-4 or.	for Assembly and Test at ASE Taiwan packages. Presently, ASEK is a qualified
Testing Manufacturing Site	MSL rating will c	change from MSL 3 to MSL 1.	
 Data Sheet Other 	Refer to Attachme the list of affected	ent 1 for the qualification summ 1 products.	ary and material set details. Attachment 2 is
RELIABILITY/OUALIEICATION SUMMA	RV.		
Qualification has passed. Pls note that the MSL	rating will change	e from MSL3 to MSL1.	
CUSTOMER ACKNOWLEDGMENT OF R IDT records indicate that you require written not to grant approval or request additional informat it will be assumed that this change is acceptable IDT reserves the right to ship either version ma on the earlier version has been depleted.	ECEIPT: otification of this c ion. If IDT does not e. nufactured after th	hange. Please use the acknowle ot receive acknowledgement wit e process change effective date	dgement below or E-Mail thin 30 days of this notice until the inventory
Customer:	Appro-	oval for shipments prior to	o effective date.
Name/Date:	E-Mail Addre	ss:	
Title:	Phone# /Fax#	:	
CUSTOMER COMMENTS:			
IDT ACKNOWLEDGMENT OF RECEIPT:			
RECD. BY:	DA	ATE:	
IDT FRA-1509-01 REV. 01 06/22/09	Page 1	l of 1	Refer To QCA-1795



PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT 1 - PCN # : A1205-02

PCN Type: Alternate Assembly & Test Location

Data Sheet Change: N/A. MSL Rating will change from MSL 3 to MSL 1.

Detail Of Change:

This change is to provide for additional capacity for Assembly and Test at ASE Taiwan (ASEK) on the selective products of VFQFPN-4 packages that are currently assembled and tested in Unisem. Presently, ASEK is a qualified IDT Subcontractor.

This change will allow IDT the flexibility to ship from either facility and will provide the increased capacity, flexibility and shorter lead time to meet market demand.

The material set details of the current Assembly location of these packages is shown in the tables below. The die attach and mold compound used at ASEK are qualified IDT materials. There is no change from the existing qualified lead frame material, lead finish, and wire for this alternate assembly site as shown in Table 1.

Table 1: Qualified Material Sets, by Assembly Subcontractor

Description	Existing	Add	
Assembly Location	Unisem, USA	ASEK - ASE, Taiwan	
	Die Attach: 8006 series	FH900 series	
	Wire: Au wire 0.8 mil	Au wire 0.8 mil	
Assembly Material Set	Mold Compound: G770 series	G631 series	
	Lead Frame: Copper Alloy	Copper Alloy	
	Plating: Matte 100% Sn (Green)	Matte 100% Sn (Green)	

There is also no change in the Test processing flows. Testers, load boards and test programs are compatible at both qualified facilities. IDT has completed the electrical test correlation and based on the test results we do not anticipate any impact on device performance. The testing is fully compatible and transferrable between the test facilities with no change to the test coverage.



PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT 1 - PCN # : A1205-02

Qualification Information and Qualification Data: <u>**Part I - Assembly Qual Results</u>**</u>

Affected Packages:	3.2mm x 5.0mm VFQFPN-4 & 2.5mm x 2.0mm VFQFPN-4
Assembly Material:	The affected package types are using ASEK standard materials shown on page 1 of this attachment. Qualification testing was completed on the worse case package.

Qual Plan & Results: Tests are in accordance with JEDEC47 recommended tests

Qualification Vehicle: 3.2mm x 5.0mm VFQFPN-4

Test Description	Test Method	Test Results (Rej / SS)		
Test Description	i est Methou	Lot 1	Lot 2	Lot 3
¹ HAST - unbiased (130 °C/85% RH, 96 Hrs)	JESD22-A110	0 / 45	0 / 45	0 / 45
¹ Temperature Cycling (-55°C to 125°C, 700 cycles)	JESD22-A104	0 / 45	0/45	0 / 45
¹ Temperature Humidity Bias (85 °C/85% RH, 1000 Hrs)	JESD22-A101	0 / 45	0 / 45	0 / 45
High Temperature Storage Test (150°C, 1000 hours)	JESD22-A103	0 / 77	0 / 77	0 / 77
Moisture Sensitivity Classification (MSL 1, 260 °C)	J-STD-020	0/25	0/25	0/25

Notes: 1. Tests were subjected to Preconditioning per JESD22-A113 @ MSL 1, 260 $^{\circ}\text{C}$

Test Description	Test Method	Test Results (Rej / SS)		
Test Description		Lot 1	Lot 2	Lot 3
Physical Dimensions	JESD22-B100	0/30	0/30	0/30
External Visual Inspection	JESD22-B101	0/25	0/25	0/25
Solderabiilty Test	JESD22-B102	0/5	0/5	0/5
X-ray Examination	MIL-STD-883, M 2015	0/45	0 / 45	0 / 45



PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT 1 - PCN # : A1205-02

Qualification Vehicle: 2.5mm x 2.0mm VFQFPN-4

Test Description	Test Method	Test Results (Rej / SS)		
Test Description	Test Methou	Lot 1	Lot 2	Lot 3
¹ HAST - unbiased (130 °C/85% RH, 96 Hrs)	JESD22-A110	0/25	0/25	0/25
¹ Temperature Cycling (-55°C to 125°C, 700 cycles)	JESD22-A104	0 / 45	0 / 45	0/45
High Temperature Storage Test (150°C, 1000 hours)	JESD22-A103	0/25	0/25	0/25
Moisture Sensitivity Classification (MSL 1, 260 °C)	J-STD-020	0/25	0/25	0/25

Notes: 1. Tests were subjected to Preconditioning per JESD22-A113 @ MSL 1, 260 °C

Tost Description	Test Method	Test Results (Rej / SS)		
Test Description		Lot 1	Lot 2	Lot 3
Physical Dimensions	JESD22-B100	0/30	0/30	0/30
External Visual Inspection	JESD22-B101	0/25	0/25	0/25
Solderabiilty Test	JESD22-B102	0/5	0/5	0/5
X-ray Examination	MIL-STD-883, M 2015	0 / 45	0 / 45	0/45



PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT 1 - PCN # : A1205-02

Qualification Information and Qualification Data: <u>Part II - Electrical Test Correlation Results</u>

Vehicle:3TN11G24.0000NSG4 (300 PPM spec)Sample size:500 electrically good units and 20 reject units

Description	Unisem, USA (Existing Facility)	ASEK - ASE, Taiwan (Alternate Facility)	
Tester Platform	Teradyne J750	Teradyne J750	
Loadboard	PCB608_868_00	J750-M8202-NSG4-U-37-01A	
Test Program	IndiumFT16R9.xls	IndiumFT16R9.xls	
Test Site	Dual site	8-site	
Test Temperature	75°C and 30°C	75°C and ambient	
Test Correlation Results	100%	100%	
Number of Good Units Correlated @ 75°C and 30°C	500 pcs	500 pcs	
500 units Bin 1 handler run (good units)	Passed	Passed	
Number of Reject Units Correlated @ 30°C	20 pcs	20 pcs	
20 units rejects handler run	Passed	Passed	
500 units Bin 1 datalog correlation (good units)	Passed	Passed	
20 units rejects datalog correlation	Passed	Passed	

Vehicle:3TN11G24.0000NVG4 (300 PPM spec)Sample size:500 electrically good units and 40 reject units

Description	Unisem, USA (Existing Facility)	ASEK - ASE, Taiwan (Alternate Facility)	
Tester Platform	Teradyne J750	Teradyne J750	
Loadboard	M8202-P24 REV.B	M8202-P24 REV.B	
Test Program	IndiumFT16R9.xls	IndiumFT16R9.xls	
Test Site	Single site	3 sites	
Test Temperature	Ambient	Ambient	
Test Correlation Results	100%	100%	
Number of Good Units Correlated @ ambient	500 pcs	500 pcs	
500 units Bin 1 handler run (good units)	Passed	Passed	
Number of Reject Units Correlated @ ambient	40 pcs	40 pcs	
40 units rejects handler run	Passed	Passed	
500 units Bin 1 datalog correlation (good units)	Passed	Passed	
40 units rejects datalog correlation	Passed	Passed	



PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT 2 - PCN # : A1205-02

Affected Part Number

Part Number	Part Number	Part Number	Part Number
8102-22.57VPCNSGT	8102-25VPCNVG	8102-6VPCNSG	8202-8VPCNSG
8102-22.57VPCNVGM	8102-40VPCNSG	8202-12VPCNVG	8203-24VPCNSGIT
8102-22.57VPCNVGMT	8102-48VPCNVGT	8202-13VPCNSG	8203-8VPCNVGIT
8102-24.576VPCNSG	8102-50VPCNSGM	8202-20VPCNSG	
8102-24VPCNVG	8102-50VPCNVG	8202-25VPCNVG	
8102-25VPCNSG	8102-50VPCNVGT	8202-80VPCNSG	